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pllection exhiormation unless it contains a valid OMB control number. Under the Paperwork Reduction Act of 1995, no persons are required to respon Complete if Known Substitute for form 1449A/PTO 09/732,927 **Application Number** INFORMATION DISCLOSURE December 11, 2000 Filing Date STATEMENT BY APPLICANT Nobuo SHIMAZU et al. First Named Inventor (use as many sheets as necessary) Unknown Group Art Unit Unknown Examiner Name Sheet Attorney Docket Number of 1 740107-135 U.S. PATENT DOCUMENTS U.S. Patent Document Date of Publication of Cited Pages, Columns, Lines, Where Relevant Cite Examiner Document MM-DD-YYYY Passages or Relevant Figures Appear Name of Patentee or Applicant of Cited Kind Code² Number 5.831.272 Utsumi 11-03-1998 FOREIGN PATENT DOCUMENTS Cite Examiner Foreign Patent Document Date of Publication of Cited Pages, Columns, Lines, Where Name of Patentee or Document MM-DD-YYYY Relevant Passages or Relevant Figures Appear Initials Applicant of Cited Document ind Code Т6 Office³ Number OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS Examiner Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the T^2 Initials' item (book, magazine, journal, serial, symposium, catalog, etc.)., date, page(s), volume-issue number(s), publisher, city and/or country where published. HIGH THROUGHPUT SUBMICRON LITHOGRAPHY WITH ELECTRON BEAM PROXIMITY PRINGING, H. BOHLEN ET AL., SOLID STATE TECHNOLOGY, SEPTEMBER 1984, PAGES 210-217 LOW ENERGY ELECTRON-BEAM PROXIMITY PROJECTION LITHOGRAPHY: DISCOVER OF MISSING LINK, TAKAO UTSUMI, J. VAC. SCI. TECHNOL. B 17(6), NOVEMBER/DECEMBER 1999, PAGES 2897-2902

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